Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/628,361	CHANG ET AL.	
Examiner	Art Unit	
Huyen X. Vo	2626	

CEAROUED				
	SEARCHED			
Class	Subclass	Date	Examiner	
704	256; 249; 250; 231; 232; 240	1/13/2007	н∨	
704	270; 242	1/13/2007	HV	
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INTERFERENCE SEARCHED			
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	DATE	EXMR
EAST search included	1/13/2007	HV
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